

HEIWA.026AUS

PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant	:	Noriaki Chiba	)	Group Art Unit
			)	
Serial No.	:	New Application	)	
			)	
Filed	:	Concurrently Herewith	)	
			)	
For	:	TIMING GENERATION CIRCUIT	)	
		AND SEMICONDUCTOR TEST	)	
		DEVICE HAVING THE TIMING	)	
		GENERATION CIRCUIT	)	
			)	
Examiner	:	Unknown	)	
			)	

PRELIMINARY AMENDMENT

Hon. Commissioner  
of Patents and Trademarks  
Alexandria, VA 22313-1450

Dear Sir:

This amendment is submitted for the above-identified patent application for correcting the forms of the claims. Please make the following changes.